

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/743,522	SHIBATA ET AL.	
Examiner	Art Unit	
Khiem D. Nguyen	2823	

SEARCHED					
Class	Subclass	Date	Examiner		
438	311	11/26/2006	K.N.		
428	131	11/26/2006	K.N.		
428	446	11/26/2006	K.N.		
430	312	11/26/2006	K.N.		
430	313	11/26/2006	K.N.		
430	296	11/26/2006	K.N.		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
		-1-			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST text search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB).	11/26/2006	K.N.		
		·		
,				